

## N-Channel 60 V (D-S) MOSFET

PRODUCT SUMMARY						
V <sub>DS</sub> (V)	R <sub>DS(on)</sub> (Ω)	I <sub>D</sub> (A) <sup>a</sup>				
60	0.024 at V <sub>GS</sub> = 10 V	50				
	0.028 at V <sub>GS</sub> = 4.5 V	40				

#### **FEATURES**

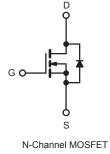
- Halogen-free According to IEC 61249-2-21 Definition
- Surface Mount
- Available in Tape and Reel
- Dynamic dV/dt Rating
- Logic-Level Gate Drive
- Fast Switching
- Compliant to RoHS Directive 2002/95/EC



Ο GDS

Top View

TO-220AB



ABSOLUTE MAXIMUM RATINGS ( $T_C$ :	= 25 °C, unl	ess otherwis	se noted)			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V <sub>DS</sub>	60	v	
Gate-Source Voltage			V <sub>GS</sub>	± 20	v	
Continuous Drain Current <sup>f</sup>	V <sub>GS</sub> at 10 V	$T_C = 25 \text{ °C}$ $T_C = 100 \text{ °C}$	I.	50		
Continuous Drain Current	VGS at 10 V	T <sub>C</sub> = 100 °C	I <sub>D</sub>	36	A	
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	200		
Linear Derating Factor				1.0	W/°C	
Linear Derating Factor (PCB Mount) <sup>e</sup>				0.025	W/ C	
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	400	mJ	
Maximum Power Dissipation T <sub>C</sub> = 25 °C			Р	150	W	
Maximum Power Dissipation (PCB Mount) <sup>e</sup> T <sub>A</sub> = 25 °C		P <sub>D</sub>	3.7	vv		
Peak Diode Recovery dV/dt <sup>c</sup>			dV/dt	4.5	V/ns	
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub> - 55 to + 175		°C	
Soldering Recommendations (Peak Temperature) <sup>d</sup> for 10 s				300 <sup>d</sup>		

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b.  $V_{DD} = 25 \text{ V}$ , starting  $T_J = 25 \text{ °C}$ ,  $L = 179 \text{ }\mu\text{H}$ ,  $R_g = 25 \Omega$ ,  $I_{AS} = 51 \text{ A}$  (see fig. 12). c.  $I_{SD} \le 51 \text{ A}$ , dl/dt  $\le 250 \text{ A/}\mu\text{s}$ ,  $V_{DD} \le V_{DS}$ ,  $T_J \le 175 \text{ °C}$ .

e. When mounted on 1" square PCB (FR-4 or G-10 material).

f. Current limited by the package, (die current = 51 A).

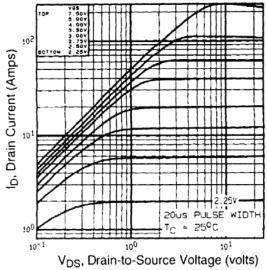
d. 1.6 mm from case.



THERMAL RESISTANCE RATI	SYMBOL	TYP		MAY			UNIT		
		ITP	•	MAX.		UNIT			
Maximum Junction-to-Ambient Maximum Junction-to-Ambient (PCB Mount) <sup>a</sup>	R <sub>thJA</sub> R <sub>thJA</sub>	-		62 40		°C/W			
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	- 1.0							
ote	"thJC			1.0					
When mounted on 1" square PCB (FR-4 of	or G-10 material	). 1							
<b>SPECIFICATIONS</b> ( $T_J = 25 \text{ °C}$ , u	nless otherw	ise noted)							
PARAMETER	SYMBOL	,	T CONDIT	ONS	MIN.	TYP.	MAX.	UNIT	
Static		4			Į	Į			
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub>	= 0, I <sub>D</sub> = 25	50 μA	60	-	-	V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$		e to 25 °C,		-	0.070	-	V/°C	
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>		= V <sub>GS</sub> , I <sub>D</sub> = 2	-	1.0	_	2.5		
Gate-Source Leakage	I <sub>GSS</sub>	-	$V_{GS} = \pm 10$		-	_	± 100	nA	
	.000				_	_	25		
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = 60 \text{ V}, V_{GS} = 0 \text{ V}$ $V_{DS} = 48 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 150 \text{ °C}$			-	-	250	μA	
		$V_{\rm DS} = 40 V_{\rm r}$		= 21 A <sup>b</sup>		0.024	200	<u> </u>	
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	$V_{GS} = 10 V$ $V_{GS} = 4.5 V$	5	= 15 A <sup>b</sup>	-	0.024		Ω	
Forward Transconductance	<i>Q</i> ,		= 25 V, I <sub>D</sub> =		23	-		S	
Dynamic	9 <sub>fs</sub>	VDS -	- 25 V, ID -	218	20	_		5	
-	<u> </u>				_	100		1	
Input Capacitance	Ciss	-	$V_{GS} = 0 V,$		-	190	_	 	
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> = 25 V, f = 1.0 MHz, see fig. 5		-	920	-	pF		
Reverse Transfer Capacitance	C <sub>rss</sub>		-	C	-	170	-	ļ	
Total Gate Charge	Qg	_	ln = 51	A $V_{DC} = 48 V$	-	-	66		
Gate-Source Charge	$Q_gs$	$V_{GS} = 5.0 \text{ V} \qquad \begin{array}{c} I_D = 51 \text{ A}, V_{DS} = 48 \text{ V}, \\ \text{see fig. 6 and } 13^{\text{b}} \end{array}$		-	-	12	nC		
Gate-Drain Charge	$Q_gd$				-	-	43		
Turn-On Delay Time	t <sub>d(on)</sub>				-	17	-		
Rise Time	t <sub>r</sub>	$V_{DD} = 30 \text{ V}, \text{ I}_{D} = 51 \text{ A},$		-	230	-	ns		
Turn-Off Delay Time	t <sub>d(off)</sub>	$R_g = 4.6 \Omega,$	$R_D = 0.56 \Omega$	2, see fig. 10 <sup>b</sup>	-	2	-		
Fall Time	t <sub>f</sub>				-	110	-		
Internal Drain Inductance	L <sub>D</sub>	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	nH		
Internal Source Inductance	L <sub>S</sub>			-	7.5	-			
Drain-Source Body Diode Characteristic	s								
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	50 <sup>c</sup>	- A		
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			-	-	200			
Body Diode Voltage	V <sub>SD</sub>	$T_{\rm J}$ = 25 °C, $I_{\rm S}$ = 51 A, $V_{\rm GS}$ = 0 V <sup>b</sup>		-	-	2.5	V		
Body Diode Reverse Recovery Time	t <sub>rr</sub>	$T_{J} = 25 \text{ °C}, I_{F} = 51 \text{ A}, dl/dt = 100 \text{ A/}\mu\text{s}^{b}$ Intrinsic turn-on time is negligible (turn-o		-	130	180	ns		
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	0.84	1.3	μC		
Forward Turn-On Time	t <sub>on</sub>			_on is dor	ninated b	v La and	· ·		

Notes
a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
b. Pulse width ≤ 300 µs; duty cycle ≤ 2 %.
c. Current limited by the package, (Die Current = 51 A).





#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



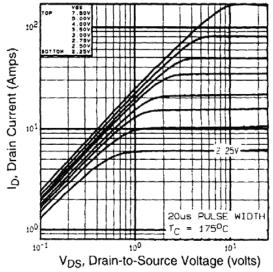
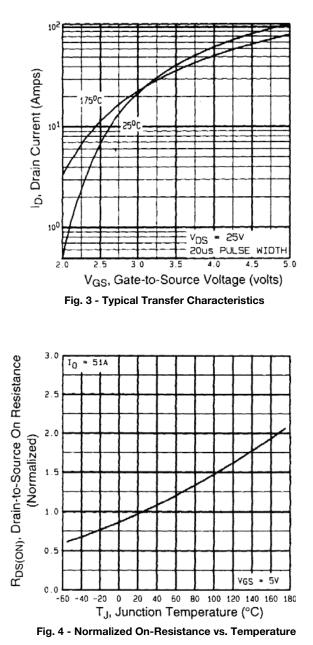


Fig. 2 - Typical Output Characteristics,  $T_C = 150$  °C





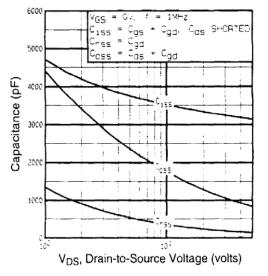


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

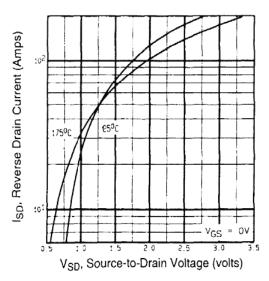
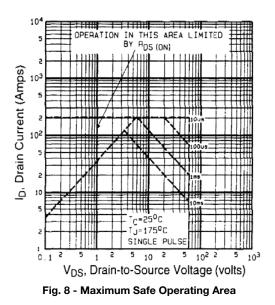


Fig. 7 - Typical Source-Drain Diode Forward Voltage



Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage





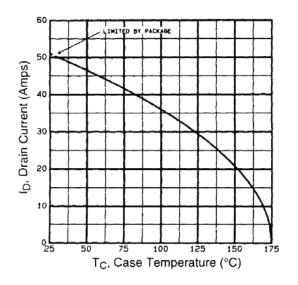


Fig. 9 - Maximum Drain Current vs. Case Temperature

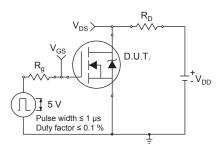


Fig. 10a - Switching Time Test Circuit

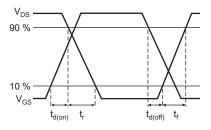
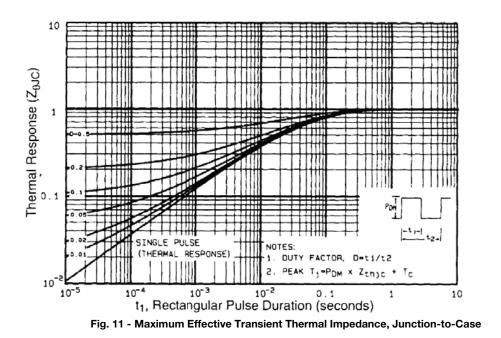


Fig. 10b - Switching Time Waveforms





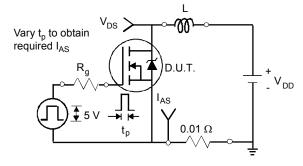


Fig. 12a - Unclamped Inductive Test Circuit

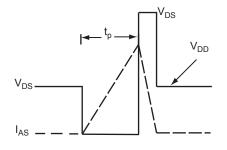


Fig. 12b - Unclamped Inductive Waveforms



Fig. 12c - Maximum Avalanche Energy vs. Drain Current

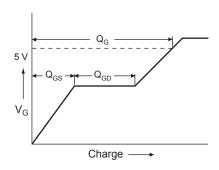


Fig. 13a - Basic Gate Charge Waveform

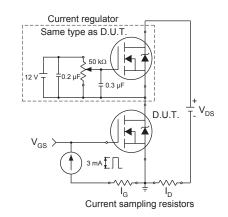
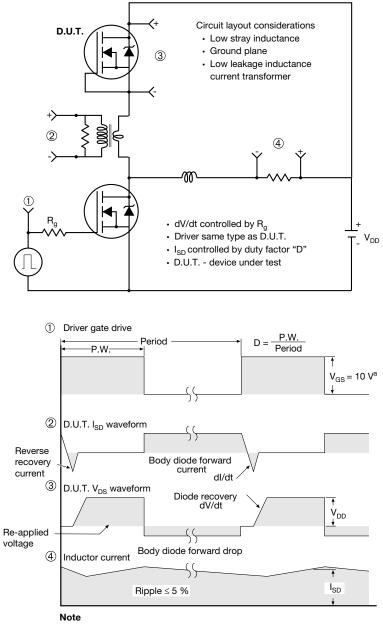


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit

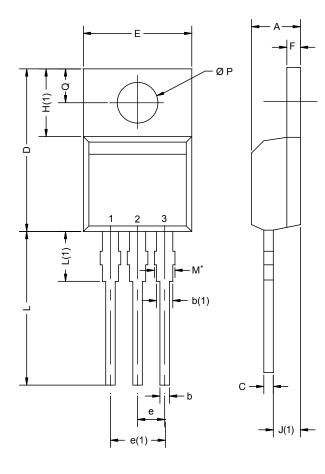


a.  $V_{GS}$  = 5 V for logic level devices

Fig. 14 - For N-Channel



### **TO-220AB**



	MILLIN	IETERS	INCHES		
DIM.	MIN.	MAX.	MIN.	MAX.	
А	4.25	4.65	0.167	0.183	
b	0.69	1.01	0.027	0.040	
b(1)	1.20	1.73	0.047	0.068	
С	0.36	0.61	0.014	0.024	
D	14.85	15.49	0.585	0.610	
E	10.04	10.51	0.395	0.414	
е	2.41	2.67	0.095	0.105	
e(1)	4.88	5.28	0.192	0.208	
F	1.14	1.40	0.045	0.055	
H(1)	6.09	6.48	0.240	0.255	
J(1)	2.41	2.92	0.095	0.115	
L	13.35	14.02	0.526	0.552	
L(1)	3.32	3.82	0.131	0.150	
ØΡ	3.54	3.94	0.139	0.155	
Q	2.60	3.00	0.102	0.118	
ECN: X12- DWG: 547	0208-Rev. N, 1	08-Oct-12			

#### Notes

\* M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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